

**Search Notes**

Application No.

10/073,427

Examiner

Matthew J Sked

Applicant(s)

CHU ET AL.

Art Unit

2655

**SEARCHED**

Class	Subclass	Date	Examiner
704	260	2/1	MS
704	258	2/1	MS

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Search attacted	2/1	MS
IEEE Search attacted	2/2	MS

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner